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LIST OF REFERENCES CITED BY APPLICANT

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Burkhard STANDKE, et al.

FILING DATE

January 4, 2002

GROUP

1773

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
MF	AA	3,012,006	12/05/61	George W. HOLBROOK, et al.			

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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
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Examiner

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Date Considered

4/7/03

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